

Notice of References Cited	Application/Control No. 10/649,334	Applicant(s)/Patent Under Reexamination TADLOCK, JOHN W.	
	Examiner Yoon-Young Kim	Art Unit 1723	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,407,571	04-1995	Rothwell, Charles N.	210/232
	B	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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